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APPLICATION NO.	LICATION NO. FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/073,751	<u> </u>	02/09/2002	Arjun Kar Roy	01CON211P	01CON211P 4492	
25700	7590	10/25/2002				
FARJAMI	FARJAMI & FARJAMI LLP EXAMINER					
16148 SAN IRVINE, C		ON		CHU, CHRIS C		
				ART UNIT	PAPER NUMBER	
				2815		
				DATE MAILED: 10/25/2002		

Please find below and/or attached an Office communication concerning this application or proceeding.

				
		Applicati n N .	applicant(s)	/
,	Office Action Occurre	10/073,751	KAR ROY ET AL.	
	Office Acti n Summary	Examiner	Art Unit	
		Chris C. Chu	2815	
Period fo	The MAILING DATE f this communication ap or Reply	pears on the cover sheet wi	th the correspondence address	
- Exte after - If the - If NC - Failu - Any I	ORTENED STATUTORY PERIOD FOR REPL MAILING DATE OF THIS COMMUNICATION. nsions of time may be available under the provisions of 37 CFR 1. SIX (6) MONTHS from the mailing date of this communication. period for reply specified above is less than thirty (30) days, a represent of the reply in the set of extended period for reply will, by statute to reply within the set or extended period for reply will, by statute the ply received by the Office later than three months after the mailing digital patent term adjustment. See 37 CFR 1.704(b).	136(a). In no event, however, may a reply within the statutory minimum of thirty will apply and will expire SIX (6) MONIC cause the application to become AR	rply be timely filed (30) days will be considered timely. THS from the mailing date of this communical ANDONED (35 U.S.C. \$423).	ation.
1)[🛛	Responsive to communication(s) filed on 05	August 2002 .		
2a) <u></u>		nis action is non-final.		
3)□	Since this application is in condition for allow		ers prosecution as to the merit	te ie
Dispositi	closed in accordance with the practice under on of Claims	Ex parte Quayle, 1935 C.D	0. 11, 453 O.G. 213.	13 13
4)⊠	Claim(s) $1 - 18$ is/are pending in the application	on.		
	4a) Of the above claim(s) is/are withdra	wn from consideration.		
	Claim(s) is/are allowed.			
6)⊠	Claim(s) <u>1 - 18</u> is/are rejected.			
7)	Claim(s) is/are objected to.			
	Claim(s) are subject to restriction and/o	or election requirement.		
	on Papers	,		
9) 🗌 🗆	The specification is objected to by the Examine	er.		
10)⊠ 7	he drawing(s) filed on <u>09 February 2002</u> is/ard	e: a)⊡ accepted or b)⊠ obje	cted to by the Examiner.	
	Applicant may not request that any objection to the	e drawing(s) be held in abeyar	nce. See 37 CFR 1.85(a).	
11)[] 7	he proposed drawing correction filed on	_ is: a) ☐ approved b) ☐ dis	sapproved by the Examiner.	
	If approved, corrected drawings are required in re	ply to this Office action.		
12) 🔲 🏻	he oath or declaration is objected to by the Ex	aminer.		
Pri rity u	nder 35 U.S.C. §§ 119 and 120			
13)	Acknowledgment is made of a claim for foreigi	n priority under 35 U.S.C. §	119(a)-(d) or (f).	
	☐ All b)☐ Some * c)☐ None of:			
	1. Certified copies of the priority document	s have been received.		
	2. Certified copies of the priority document		plication No.	
	3. Copies of the certified copies of the prio application from the International Buse the attached detailed Office action for a list	rity documents have been re reau (PCT Rule 17.2(a)).	eceived in this National Stage	
	Cknowledgment is made of a claim for domesti			ation).
15)□ A	The translation of the foreign language procedure. The translation of the foreign language procedures.	ic priority under 35 U.S.C. &	en received. & 120 and/or 121	
Attachment(p, under 00 0.0.0. g	3 120 and/01 121.	
	of References Cited (PTO-892)	4) T Interview St	ımmary (PTO-413) Paper No(s).	
2) Notice	of Draftsperson's Patent Drawing Review (PTO-948)	5) Notice of Inf	formal Patent Application (PTO-152)	- ·
	ation Disclosure Statement(s) (PTO-1449) Paper No(s)	6)	•	
S. Patent and Tra PTO-326 (Rev		tion Summary	Part of Paper N	lo. 5

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DETAILED ACTION

Election/Restrictions

1. Applicant's election without traverse of Group I in Paper No. 2 is acknowledged.

Drawings

- 2. The drawings are objected to as failing to comply with 37 CFR 1.84(p)(5) because they include the following reference sign(s) not mentioned in the description: in Fig. 11, reference numeral "1100" is not disclosed in the specification of instant invention. A proposed drawing correction, corrected drawings, or amendment to the specification to add the reference sign(s) in the description, are required in reply to the Office action to avoid abandonment of the application. The objection to the drawings will not be held in abeyance.
- 3. The drawings are objected to under 37 CFR 1.83(a). The drawings must show every feature of the invention specified in the claims. Therefore, the following limitations in claim 10 "a first intermediate via connected to a first terminal of said metal resistor, the first intermediate via being further connected to a first metal segment patterned in the <u>first</u> interconnect metal layer and a second intermediate via connected to a second terminal of the metal resistor, the second intermediate via being further connected to a second metal segment

patterned in <u>the first interconnect metal layer</u>" must be shown or the feature(s) canceled from the claim(s). No new matter should be entered.

A proposed drawing correction or corrected drawings are required in reply to the Office action to avoid abandonment of the application. The objection to the drawings will not be held in abeyance.

4. Applicant is required to submit a proposed drawing correction in reply to this Office action. However, formal correction of the noted defect may be deferred until after the examiner has considered the proposed drawing correction. Failure to timely submit the proposed drawing correction will result in the abandonment of the application.

Claim Rejections - 35 USC § 112

5. The following is a quotation of the first paragraph of 35 U.S.C. 112:

The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.

6. Claim 10 is rejected under 35 U.S.C. 112, first paragraph, as containing subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention.

In claim 10, the specification fails to disclose the **first intermediate via** connected to a first terminal of said **metal resistor**, the first intermediate via being further connected to a first

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metal segment patterned in the <u>first interconnect metal layer</u> and a second intermediate via <u>connected to</u> a second terminal of the **metal resistor**, the second intermediate via being further connected to a second metal segment patterned in <u>the first interconnect metal layer</u>.

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Claim Rejections - 35 USC § 102

7. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

8. Claims 10 and 16 are rejected under 35 U.S.C. 102(b) as being anticipated by Tsunemitsu et al.

Regarding claim 10, Tsunemitsu et al. discloses in Fig. 2 an integrated circuit chip comprising:

- a first interconnect metal layer (14);
- a first intermetallic dielectric layer (15) situated over said first interconnect metal layer;
- a metal resistor (16) situated over said first intermetallic dielectric layer and below a second intermetallic dielectric layer (17);
- a second interconnect metal layer (28) over said second intermetallic dielectric layer;
- a first intermediate via (the place of a connecting structure between 14 and 16, the left) connected to a first terminal of said metal resistor, the first intermediate via

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being further connected to a first metal segment patterned in the first interconnect metal layer;

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a second intermediate via (the place of a connecting structure between 14 and 16, the right) connected to a second terminal of the metal resistor, the second intermediate via being further connected to a second metal segment patterned in the first interconnect metal layer.

Regarding claim 16, Tsunemitsu et al. discloses in Fig. 2 and column 3, line 41 the first interconnect metal layer (14) comprising aluminum.

Claim Rejections - 35 USC § 103

- 9. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 10. Claims 1 and 3 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunemitsu et al. in view of Kumar.

Regarding claim 1, Tsunemitsu et al. discloses in Fig. 2 an integrated circuit chip comprising:

- a first interconnect metal layer (14);

- a first intermetallic dielectric layer (15) situated over said first interconnect metal layer;
- a metal resistor (16) situated over said first intermetallic dielectric layer and below a second intermetallic dielectric layer (17);
- a second interconnect metal layer (28) over said second intermetallic dielectric layer;
- a first intermediate via (the place of a connecting structure between 16 and 28) connected to a first terminal of said metal resistor, said first intermediate via being further connected to a first metal segment patterned in said second interconnect metal layer.

Tsunemitsu et al. does not disclose the claimed invention except for a second intermediate via and a second metal segment patterned in the second interconnect metal layer. However, Kumar discloses in Fig. 30 a second intermediate via (84, second from left) connected to a second terminal of a metal resistor (48), the second intermediate via being further connected to a second metal segment patterned (94) in a second interconnect metal layer. Thus, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Tsunemitsu et al. by using the second intermediate via and the second metal segment patterned in the second interconnect metal layer as taught by Kumar. The ordinary artisan would have been motivated to modify Tsunemitsu et al. in the manner described above for at least the purpose of increasing electrical connections (column 5, line 50).

Regarding claim 3, Tsunemitsu et al. discloses in Fig. 2 and column 3, line 41 the first interconnect metal layer (14) comprising aluminum.

11. Claim 2 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunemitsu et al. and Kumar as applied to claim 1 above, and further in view of Kato et al.

Tsunemitsu et al. and Kumar disclose the claimed invention except for the metal resistor being tantalum nitride. However, Kato et al. discloses in column 3, lines $32 \sim 33$ a metal resistor being tantalum nitride. Thus, it would have been obvious to one of ordinary skill in the art at the time the invention was made to further modify Tsunemitsu et al. by using tantalum nitride for the metal resistor as taught by Kato et al. The ordinary artisan would have been motivated to further modify Tsunemitsu et al. in the manner described above for at least the purpose of preventing a short circuit problem (column 3, lines 35 and 36).

12. Claims 4 and 5 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunemitsu et al. in view of Kumar.

Tsunemitsu et al. discloses the claimed invention except for the first intermetallic dielectric layer comprising silicon dioxide and the second intermetallic dielectric layer comprising undoped silica glass. However, it is well known in the art to use silicon dioxide for the first intermetallic dielectric layer and undoped silica glass for the second intermetallic dielectric layer. It would have been obvious to one having ordinary skill in the art at the time the invention was made to use silicon dioxide for the first intermetallic dielectric layer and undoped silica glass for the second intermetallic dielectric layer, since it has been held to be within the general skill of a worker in the art to select a known material on the basis of its suitability for the intended use as a matter of obvious design choice. In re Leshin, 125 USPQ 416. The ordinary

artisan would have been motivated to modify Tsunemitsu et al. in the manner described above for at least the purpose of providing electronic ceramics in the package.

Further, as to the language on line 2 of claim 4, "HDPCVD", even though product-by-process claims are limited by and defined by the process, determination of patentability is based upon the product itself. The patentability of a product does not depend on its method of production. If the product in product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product is made by a different process. In re Thorpe, 227 USPQ 964, 966 (Fed. Cir. 1985) (citations omitted). A "product by process" claim is directed to the product per se, no matter how actually made, In re Hirao, 190 USPQ 15 at 17 (footnote 3). See also In re Brown, 173 USPQ 685: In re Luck, 177 USPQ 523; In re Fessmann, 180 USPQ 324: In re Avery, 186 USPQ 116; In re Wertheim, 191 USPQ 90 (209 USPQ 254 does not deal with this issue); and In re Marosi et al., 218 USPQ 289 final product per se which must be determined in a "product by, all of" claim, and not the patentability of the process, and that an old or obvious product, whether claimed in "product by process" claims or not. Note that Applicant has the burden of proof in such cases, as the above caselaw makes clear.

13. Claims 6 and 7 are rejected under 35 U.S.C. 103(a) as being unpatentable over
Tsunemitsu et al. and Kumar as applied to claim 1 above, and further in view of Yaung et al.

Regarding claim 6, Tsunemitsu et al. and Kumar disclose the claimed invention except for a dielectric cap layer. However, Yaung et al. discloses in Fig. 4 a dielectric cap layer (30) situating between a resistor (26) and a second intermetallic dielectric layer (34). Thus, it would

have been obvious to one of ordinary skill in the art at the time the invention was made to further modify Tsunemitsu et al. by using the dielectric cap layer as taught by Yaung et al. The ordinary artisan would have been motivated to further modify Tsunemitsu et al. in the manner described above for at least the purpose of providing precisely controlled resistance (column 2, lines 10 ~ 12).

Regarding claim 7, Yaung et al. discloses in column 3, line 49 the dielectric cap layer comprising silicon nitride.

14. Claims 8 and 9 are rejected under 35 U.S.C. 103(a) as being unpatentable over
Tsunemitsu et al. and Kumar as applied to claim 1 above, and further in view of Ohkawa et al.

Regarding claim 8, Tsunemitsu et al. and Kumar disclose the claimed invention except for an oxide cap layer. However, Ohkawa et al. discloses in Fig. 8 an oxide cap layer (5) situating between a metal resistor (4) and a dielectric layer (63). Thus, it would have been obvious to one of ordinary skill in the art at the time the invention was made to further modify Tsunemitsu et al. by using the oxide cap layer as taught by Ohkawa et al. The ordinary artisan would have been motivated to further modify Tsunemitsu et al. in the manner described above for at least the purpose of reducing the influence of the reflected light from the lower layer of the laser beams (column 3, lines 1 ~ 7).

Regarding claim 9, Ohkawa et al. discloses in column 4, lines 33 and 34 the oxide cap layer comprising silicon dioxide. Further, as to the language on line 2 of claim 9, "PECVD", even though product-by-process claims are limited by and defined by the process, determination of patentability is based upon the product itself. The patentability of a product does not depend

on its method of production. If the product in product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product is made by a different process. In re Thorpe, 227 USPQ 964, 966 (Fed. Cir. 1985) (citations omitted). A "product by process" claim is directed to the product per se, no matter how actually made, In re Hirao, 190 USPQ 15 at 17 (footnote 3). See also In re Brown, 173 USPQ 685: In re Luck, 177 USPQ 523; In re Fessmann, 180 USPQ 324: In re Avery, 186 USPQ 116; In re Wertheim, 191 USPQ 90 (209 USPQ 254 does not deal with this issue); and In re Marosi et al., 218 USPQ 289 final product per se which must be determined in a "product by, all of" claim, and not the patentability of the process, and that an old or obvious product, whether claimed in "product by process" claims or not. Note that Applicant has the burden of proof in such cases, as the above caselaw makes clear.

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15. Claim 11 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunemitsu et al. in view of Kato et al.

Regarding claim 11, Tsunemitsu et al. discloses the claimed invention except for the metal resistor being tantalum nitride. However, Kato et al. discloses in column 3, lines $32 \sim 33$ a metal resistor being tantalum nitride. Thus, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Tsunemitsu et al. by using tantalum nitride for the metal resistor as taught by Kato et al. The ordinary artisan would have been motivated to modify Tsunemitsu et al. in the manner described above for at least the purpose of preventing a short circuit problem (column 3, lines 35 and 36).

16. Claims 12 and 13 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunemitsu et al.

Tsunemitsu et al. discloses the claimed invention except for the first intermetallic dielectric layer comprising silicon dioxide and the second intermetallic dielectric layer comprising undoped silica glass. However, it is well known in the art to use silicon dioxide for the first intermetallic dielectric layer and undoped silica glass for the second intermetallic dielectric layer. It would have been obvious to one having ordinary skill in the art at the time the invention was made to use silicon dioxide for the first intermetallic dielectric layer and undoped silica glass for the second intermetallic dielectric layer, since it has been held to be within the general skill of a worker in the art to select a known material on the basis of its suitability for the intended use as a matter of obvious design choice. In re Leshin, 125 USPQ 416. The ordinary artisan would have been motivated to modify Tsunemitsu et al. in the manner described above for at least the purpose of providing electronic ceramics in the package.

Further, as to the language on line 2 of claim 12, "HDPCVD", even though product-by-process claims are limited by and defined by the process, determination of patentability is based upon the product itself. The patentability of a product does not depend on its method of production. If the product in product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product is made by a different process. In re Thorpe, 227 USPQ 964, 966 (Fed. Cir. 1985) (citations omitted). A "product by process" claim is directed to the product per se, no matter how actually made, In re Hirao, 190 USPQ 15 at 17 (footnote 3). See also In re Brown, 173 USPQ 685: In re Luck, 177 USPQ 523; In re Fessmann, 180 USPQ 324: In re Avery, 186 USPQ 116; In re Wertheim, 191 USPQ 90

(209 USPQ 254 does not deal with this issue); and In re Marosi et al., 218 USPQ 289 final product per se which must be determined in a "product by, all of" claim, and not the patentability of the process, and that an old or obvious product, whether claimed in "product by process" claims or not. Note that Applicant has the burden of proof in such cases, as the above caselaw makes clear.

17. Claims 14 and 15 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunemitsu et al. in view of Yaung et al.

Regarding claim 14, Tsunemitsu et al. discloses the claimed invention except for a dielectric cap layer. However, Yaung et al. discloses in Fig. 4 a dielectric cap layer (30) situating between a resistor (26) and a second intermetallic dielectric layer (34). Thus, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Tsunemitsu et al. by using the dielectric cap layer as taught by Yaung et al. The ordinary artisan would have been motivated to modify Tsunemitsu et al. in the manner described above for at least the purpose of providing precisely controlled resistance (column 2, lines $10 \sim 12$).

Regarding claim 15, Yaung et al. discloses in column 3, line 49 the dielectric cap layer comprising silicon nitride.

18. Claims 17 and 18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tsunemitsu et al. in view of Ohkawa et al.

Regarding claim 17, Tsunemitsu et al. discloses the claimed invention except for an oxide cap layer. However, Ohkawa et al. discloses in Fig. 8 an oxide cap layer (5) situating between a

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metal resistor (4) and a dielectric layer (63). Thus, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Tsunemitsu et al. by using the oxide cap layer as taught by Ohkawa et al. The ordinary artisan would have been motivated to modify Tsunemitsu et al. in the manner described above for at least the purpose of reducing the influence of the reflected light from the lower layer of the laser beams (column 3, lines $1 \sim 7$).

Regarding claim 18, Ohkawa et al. discloses in column 4, lines 33 and 34 the oxide cap layer comprising silicon dioxide. Further, as to the language on line 2 of claim 9, "PECVD", even though product-by-process claims are limited by and defined by the process, determination of patentability is based upon the product itself. The patentability of a product does not depend on its method of production. If the product in product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product is made by a different process. In re Thorpe, 227 USPQ 964, 966 (Fed. Cir. 1985) (citations omitted). A "product by process" claim is directed to the product per se, no matter how actually made, In re Hirao, 190 USPQ 15 at 17 (footnote 3). See also In re Brown, 173 USPQ 685: In re Luck, 177 USPO 523; In re Fessmann, 180 USPO 324: In re Avery, 186 USPO 116; In re Wertheim, 191 USPQ 90 (209 USPQ 254 does not deal with this issue); and In re Marosi et al., 218 USPQ 289 final product per se which must be determined in a "product by, all of" claim, and not the patentability of the process, and that an old or obvious product, whether claimed in "product by process" claims or not. Note that Applicant has the burden of proof in such cases, as the above caselaw makes clear.

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Conclusion

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19. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Inoue et al., New et al. and Kusano et al. disclose a resistor.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Chris C. Chu whose telephone number is (703) 305-6194. The examiner can normally be reached on M-F (10:30 - 7:00).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Eddie C. Lee can be reached on (703) 308-1690. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 308-7382 for regular communications and (703) 308-7722 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

c.c.

October 23, 2002

Chris C. Chu Examiner Art Unit 2815

EDDIE LEE

SUPERVICIONY PAYENT EXAMINER
12011-01-02 CENTER 2800